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Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No 28953.2004	Application No. 10/354, 840
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Makoto IW	10/594846
		Filing Date 11/08/2006 Herewith	Group Art Unit 1792

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Examiner Signature /Felisa Hiteshew/	Date Considered 04/11/2008			
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.				